

**Search Notes**

Application/Control No.

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Examiner

Hai L. Nguyen

Applicant(s)/Patent under  
Reexamination

KOIKE, HIDEHARU

Art Unit

2816

**SEARCHED**

Class	Subclass	Date	Examiner
327	551,552, 309-311, 313,318	5/18/2005	HLN
	319,321		
	327,328		
	379,180		
361	91.1,225		
257	355-357		
Update	Search	10/30/2005	HLN
Update	Search	2/2/2006	HLN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
See	Printout	2/3/2006	HLN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Shepardize Search, see search history printout	9/29/2005	HLN
Shepardize Search, see search history printout	10/31/2005	HLN